

OVA 2.0: Embedding Methods II

CS3102 EDA

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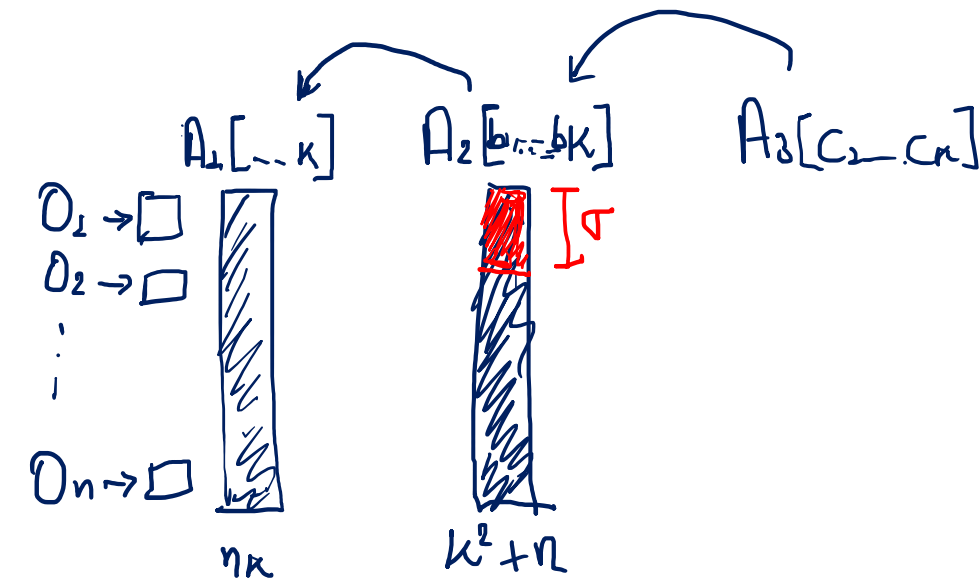
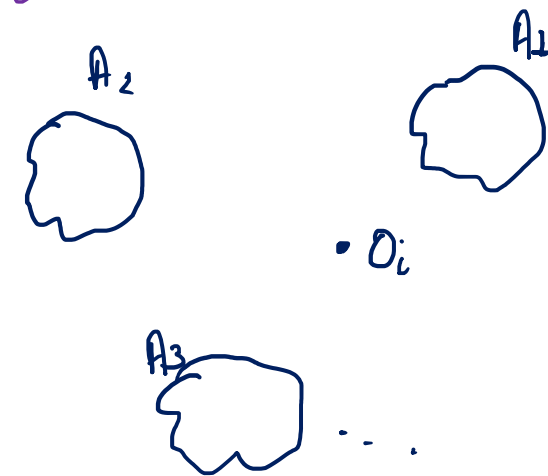
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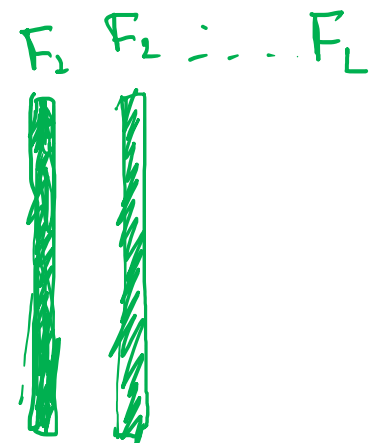
1. SparseMap

SparseMap ^{$\downarrow (F_{(o_i)}, F_{(b_i)})$}

Paso 1



Paso 2

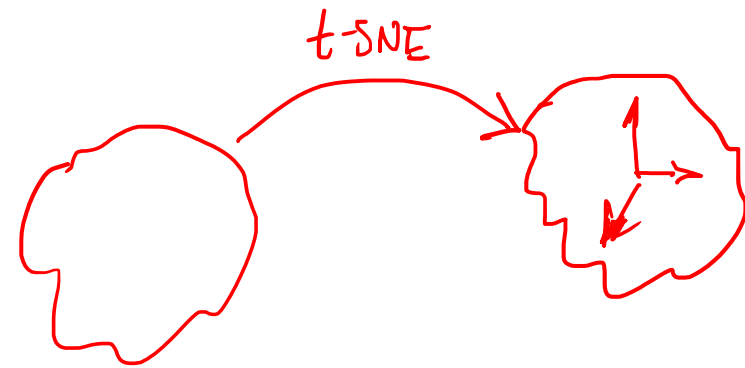


Seleccionamos los features
con menor stress

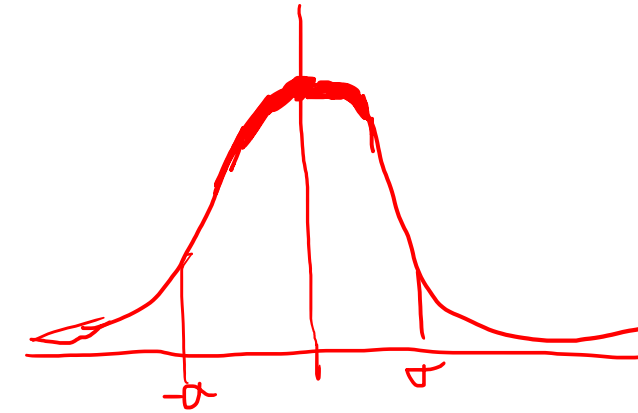
2. t-SNE

***t**-SNE*





t-SNE



Dado un conjunto de N datos x_1, \dots, x_N , se calcula las probabilidades p_{ij} que son proporcionales a la similaridad entre los datos

distribución datos reales

$$p(j|i) = \frac{e^{-\frac{\|x_i - x_j\|^2}{2\sigma_i^2}}}{\sum_{k \neq i} e^{-\frac{\|x_i - x_k\|^2}{2\sigma_i^2}}}$$

Definimos:

$$p_{ij} = \frac{p(j|i) + p(i|j)}{2N}$$

t-SNE

Dado un conjunto de N datos x_1, \dots, x_N , se calcula las probabilidades p_{ij} que son proporcionales a la similaridad entre los datos

datos original

$$p(j|i) = \frac{e^{-\frac{\|x_i - x_j\|^2}{2\sigma_i^2}}}{\sum_{k \neq i} e^{-\frac{\|x_i - x_k\|^2}{2\sigma_i^2}}}$$

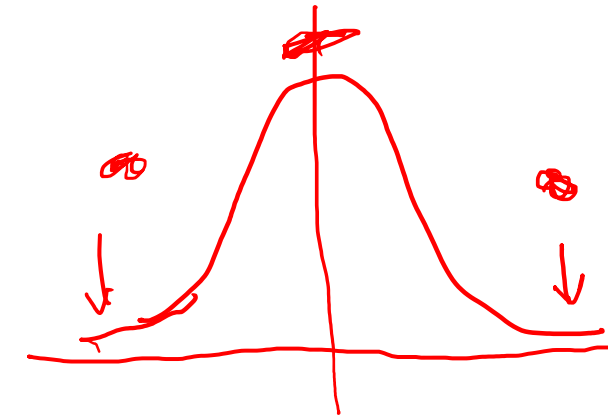
salida

$$q(j|i) = \frac{e^{-\frac{\|y_i - y_j\|^2}{2\sigma_i^2}}}{\sum_{k \neq i} e^{-\frac{\|y_i - y_k\|^2}{2\sigma_i^2}}}$$

Definimos:

$$p_{ij} = \frac{p(j|i) + p(i|j)}{2N}$$

t-SNE



Dado un conjunto de N datos x_1, \dots, x_N , se calcula las probabilidades p_{ij} que son proporcionales a la similitud entre los datos

$$p(j|i) = \frac{e^{-\frac{\|x_i - x_j\|^2}{2\sigma_i^2}}}{\sum_{k \neq i} e^{-\frac{\|x_i - x_k\|^2}{2\sigma_i^2}}}$$

$$q(j|i) = \frac{e^{-\frac{\|y_i - y_j\|^2}{2\sigma_i^2}}}{\sum_{k \neq i} e^{-\frac{\|y_i - y_k\|^2}{2\sigma_i^2}}}$$

Definimos:

$$p_{ij} = \frac{p(j|i) + p(i|j)}{2N}$$

$$q_{ij} = \frac{(1 + \|y_i - y_j\|^2)^{-1}}{\sum_k \sum_{k \neq l} (1 + \|y_k - y_l\|^2)^{-1}}$$

t-SNE

Distribución de los datos originales

$$p_{ij} = \frac{p(j|i) + p(i|j)}{2N}$$

Distribución final

$$q_{ij} = \frac{\left(1 + \|y_i - y_j\|^2\right)^{-1}}{\sum_k \sum_{k \neq l} \left(1 + \|y_k - y_l\|^2\right)^{-1}}$$

$$\text{KL}(P||Q) = \sum_{i \neq j} p_{ij} \log \frac{p_{ij}}{q_{ij}}$$

t-SNE

Algorithm 1: Simple version of t-Distributed Stochastic Neighbor Embedding.

Data: data set $\mathcal{X} = \{x_1, x_2, \dots, x_n\}$,

cost function parameters: perplexity $Perp$,

optimization parameters: number of iterations T , learning rate η , momentum $\alpha(t)$.

Result: low-dimensional data representation $\mathcal{Y}^{(T)} = \{y_1, y_2, \dots, y_n\}$.

begin

 compute pairwise affinities $p_{j|i}$ with perplexity $Perp$ (using Equation 1)

 set $p_{ij} = \frac{p_{j|i} + p_{i|j}}{2n}$

 sample initial solution $\mathcal{Y}^{(0)} = \{y_1, y_2, \dots, y_n\}$ from $\mathcal{N}(0, 10^{-4}I)$

for $t=1$ **to** T **do**

 compute low-dimensional affinities q_{ij} (using Equation 4)

 compute gradient $\frac{\delta C}{\delta \mathcal{Y}}$ (using Equation 5)

 set $\mathcal{Y}^{(t)} = \mathcal{Y}^{(t-1)} + \eta \frac{\delta C}{\delta \mathcal{Y}} + \alpha(t) (\mathcal{Y}^{(t-1)} - \mathcal{Y}^{(t-2)})$

end

end



t-SNE

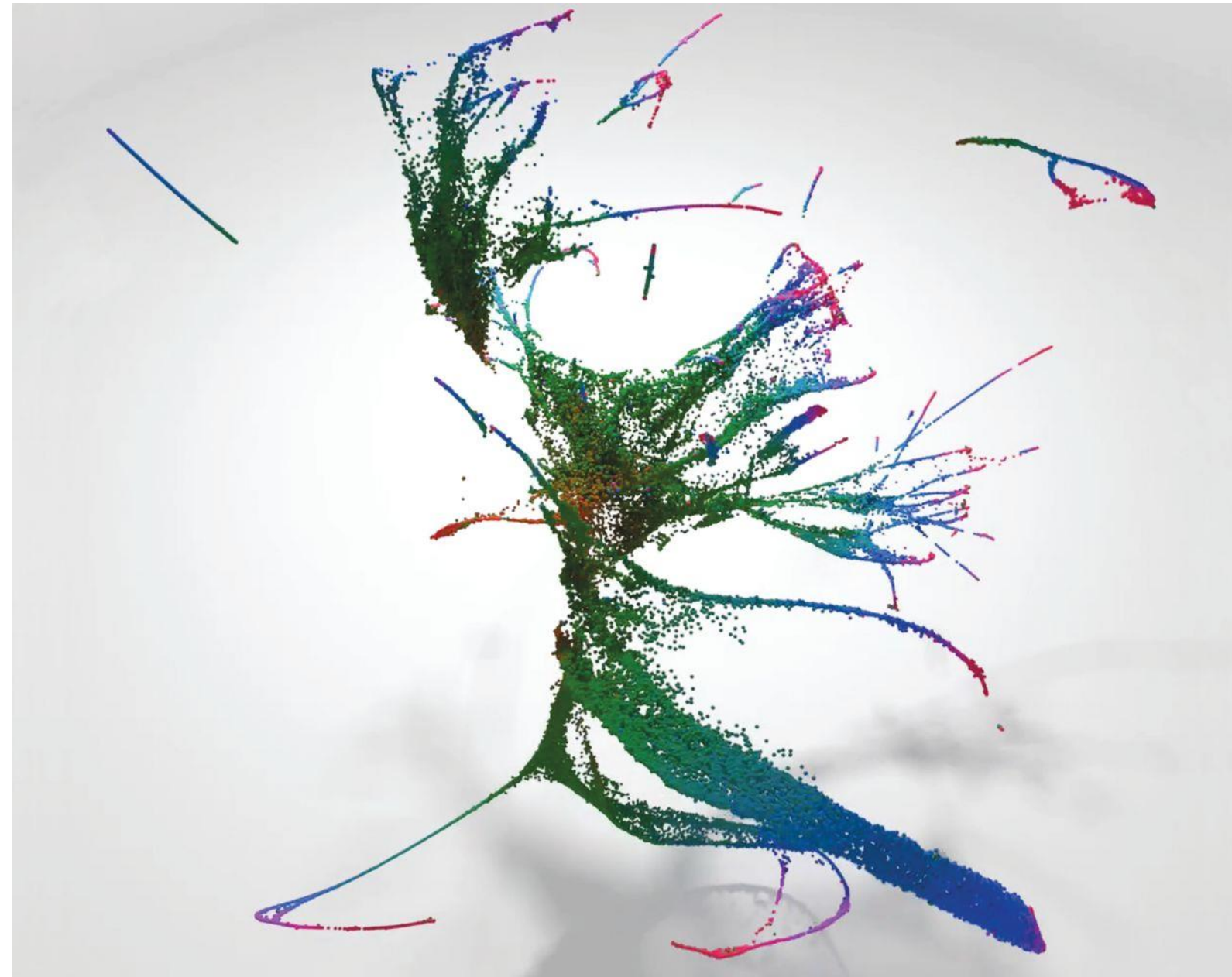
<https://distill.pub/2016/misread-tsne/>

3. UMAP



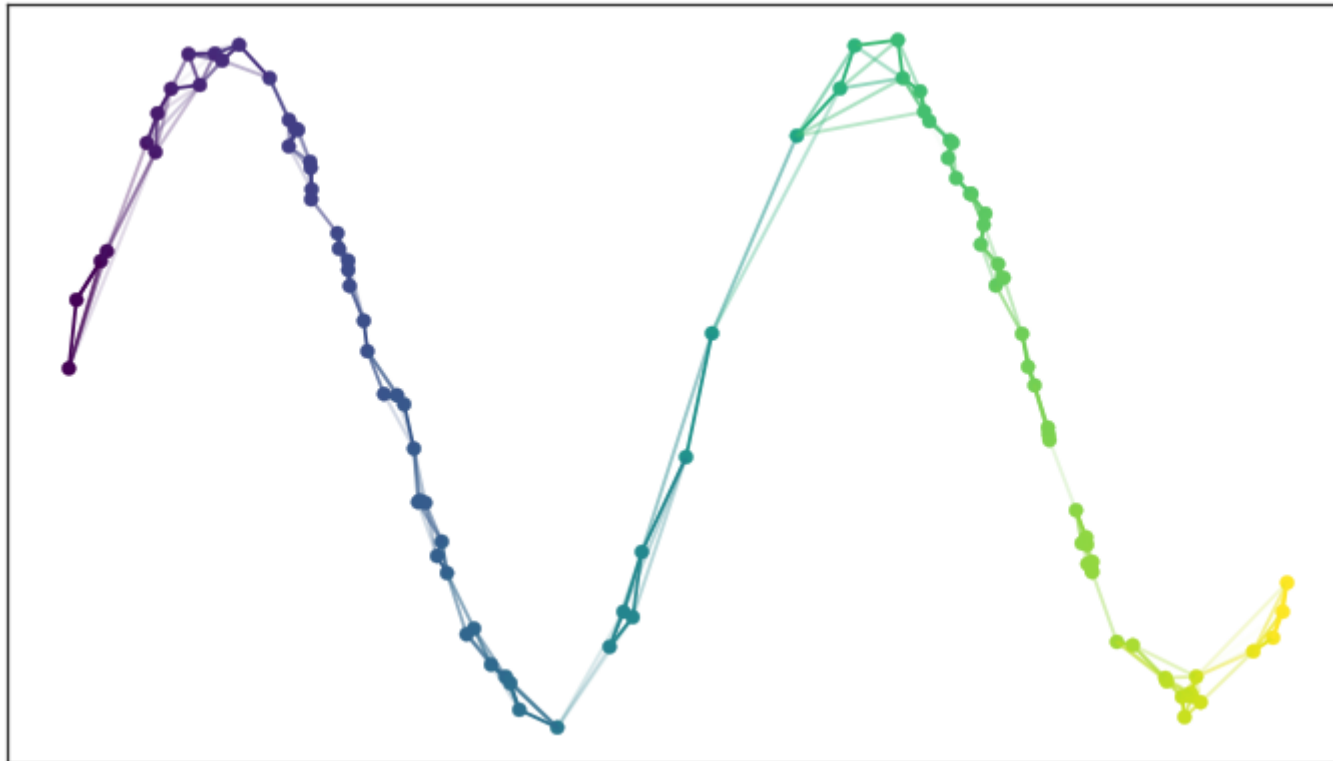
UMAP

(Uniform Manifold Approximation and Projection for Dimension Reduction)



UMAP

(Uniform Manifold Approximation and Projection for Dimension Reduction)

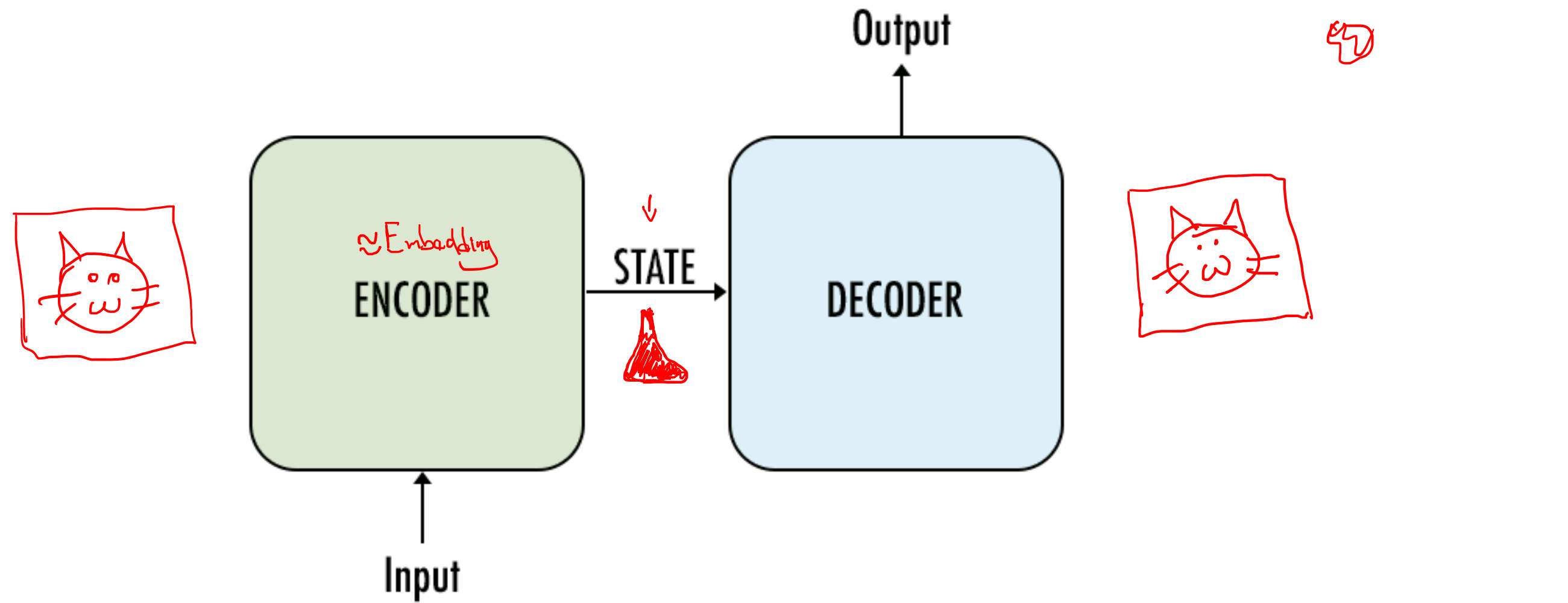


Binary cross-entropy

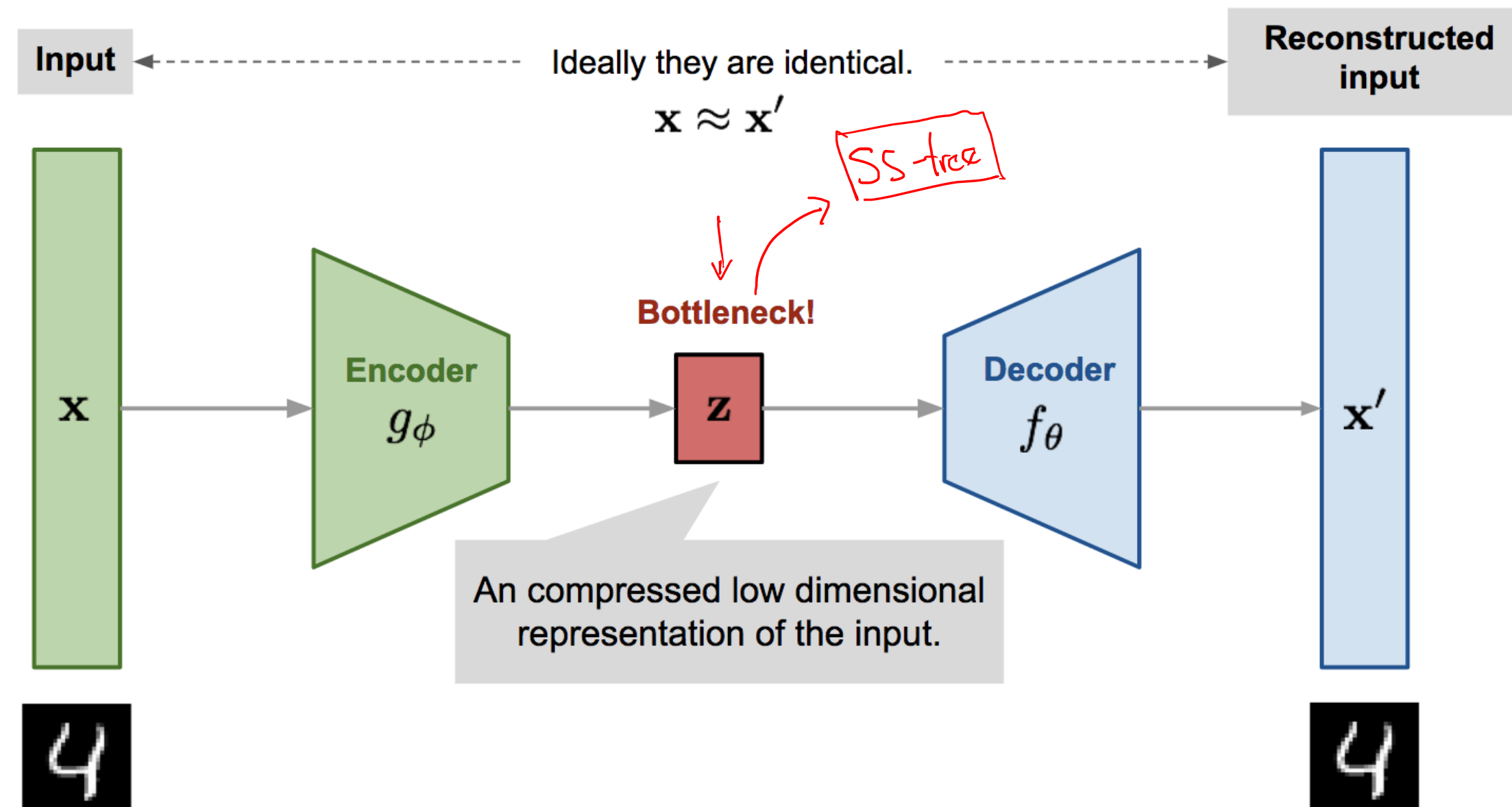
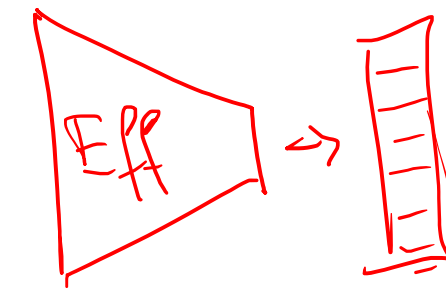
$$CE(X, Y) = \sum_i \sum_j \left[p_{ij}(X) \log \left(\frac{p_{ij}(X)}{q_{ij}(Y)} \right) + (1 - p_{ij}(X)) \log \left(\frac{1 - p_{ij}(X)}{1 - q_{ij}(Y)} \right) \right]$$

4. AutoEncoder

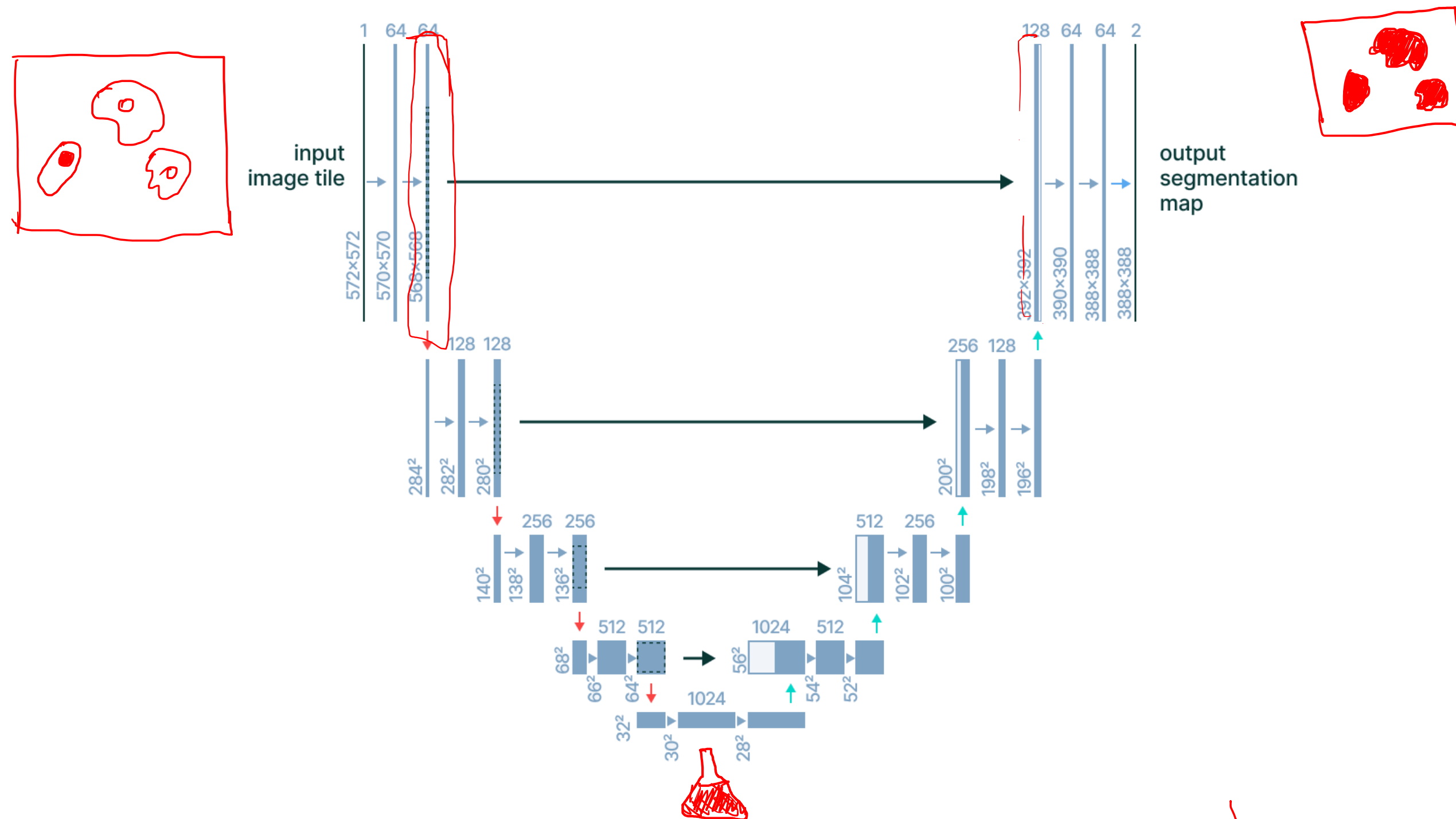
AutoEncoder



AutoEncoder

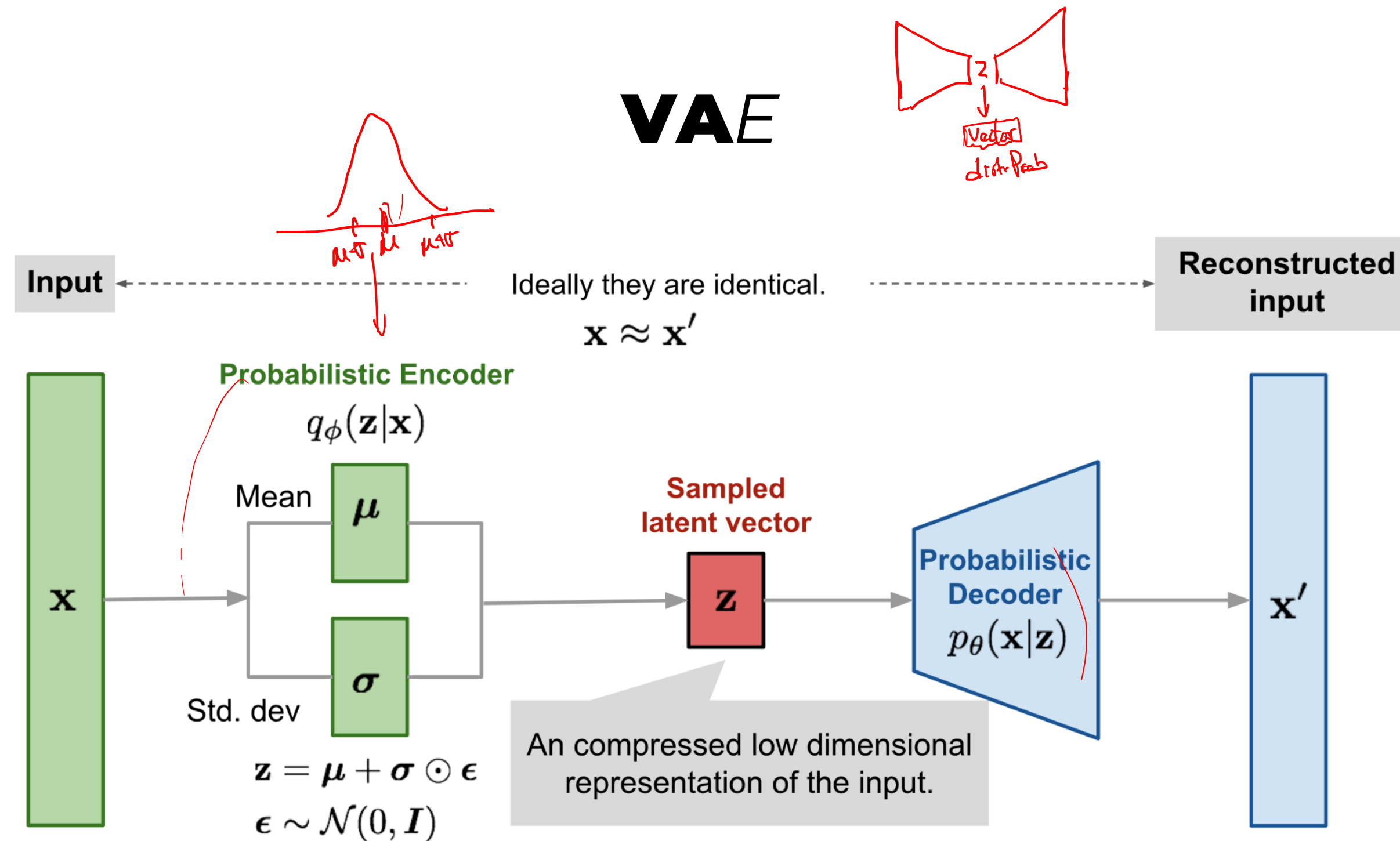


AutoEncoder



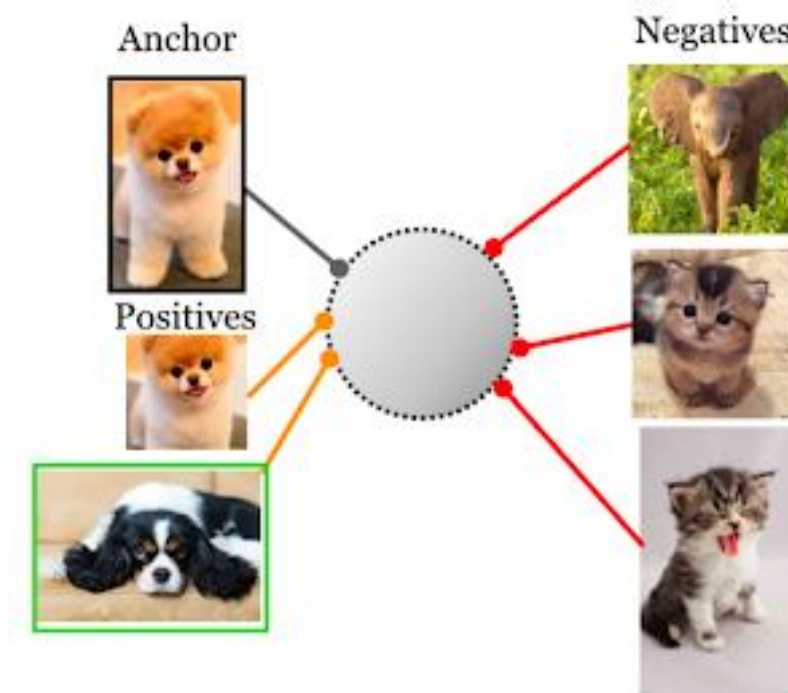
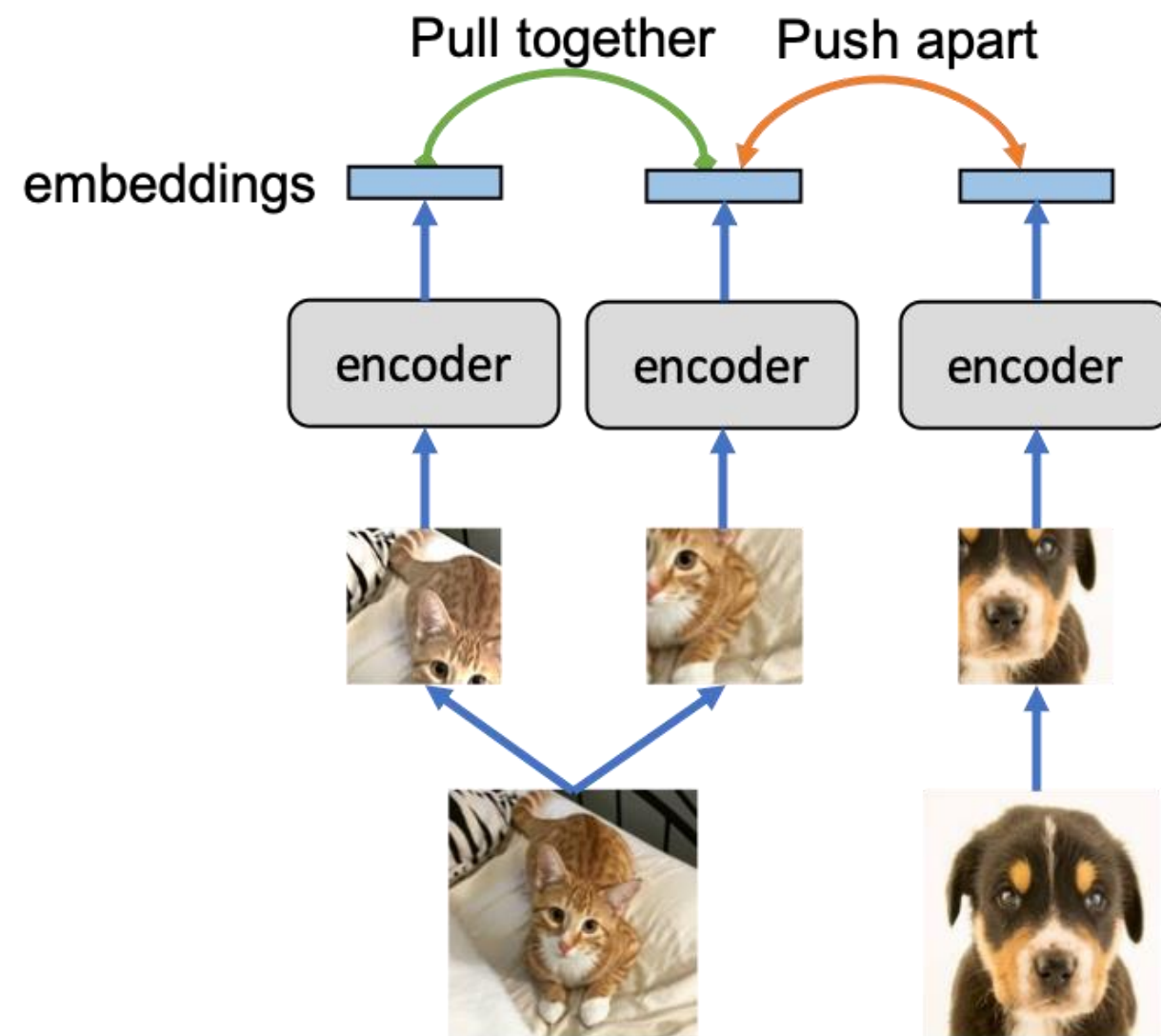
Auto*Encoder*

<https://projector.tensorflow.org/>

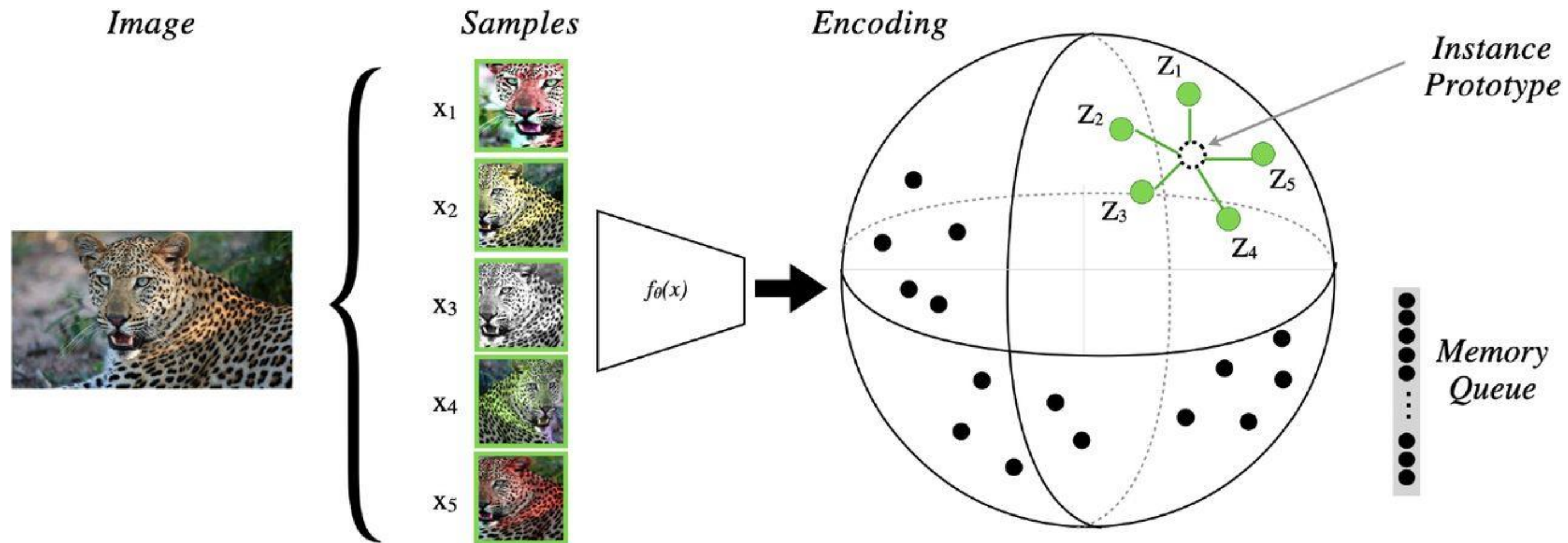


$$\mathcal{L}(\phi, \beta) = -\mathbb{E}_{\mathbf{z} \sim q_{\phi}(\mathbf{z}|\mathbf{x})} \log p_{\theta}(\mathbf{x}|\mathbf{z}) + \beta D_{\text{KL}}(q_{\phi}(\mathbf{z}|\mathbf{x}) || p_{\theta}(\mathbf{z}))$$

Contrastive Learning



Contrastive Learning





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